



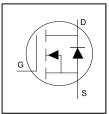
## **Application**

- Brushed Motor drive applications
- BLDC Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

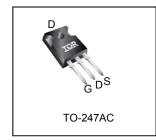
### **Benefits**

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free, RoHS Compliant

# HEXFET® Power MOSFET

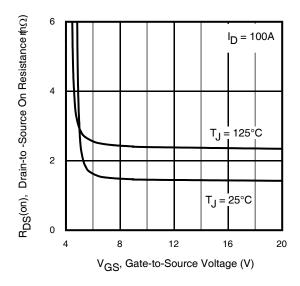


V <sub>DSS</sub>	75V
R <sub>DS(on) typ.</sub>	1.45m $\Omega$
max	$1.80$ m $\Omega$
D (Silicon Limited)	355A①
I <sub>D (Package Limited)</sub>	195A



G	D	S
Gate	Drain	Source

Base next number	Dookogo Typo	Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	
IRFP7718PbF	TO-247	Tube	25	IRFP7718PbF





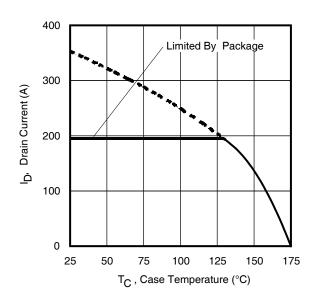


Fig 2. Maximum Drain Current vs. Case Temperature

2015-11-30



## **Absolute Maximium Rating**

Symbol	Parameter	Max.	Units
$I_D$ @ $T_C$ = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	<b>355</b> ①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	250①	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Wire Bond Limited)	195	A
I <sub>DM</sub>	Pulsed Drain Current ②	1590⑩	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	517	W
	Linear Derating Factor	3.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 Screw	10 lbf·in (1.1 N·m)	

### **Avalanche Characteristics**

E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy ③	1160	m l
E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy	2004	mJ
I <sub>AR</sub>	Avalanche Current ②	Coo Fig 14 15 220 22b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ②	See Fig 14, 15, 23a, 23b	mJ

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ hetaJC}$	Junction-to-Case ®		0.29	
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.24		°C/W
$R_{\theta JA}$	Junction-to-Ambient		40	

Static @ T<sub>1</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	75			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		42		mV/°C	Reference to 25°C, I <sub>D</sub> = 2mA ②
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		1.45	1.80	m()	$V_{GS} = 10V, I_D = 100A$
			1.60		mΩ	$V_{GS} = 6V, I_D = 50A$
$V_{GS(th)}$	Gate Threshold Voltage	2.1		3.7	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
	Drain-to-Source Leakage Current			1.0	۸	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}$
I <sub>DSS</sub>				150	μΑ	$V_{DS} = 75V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			100	nΛ	$V_{GS} = 20V$
I <sub>GSS</sub>				-100	nA	$V_{GS} = -20V$
$R_G$	Gate Resistance		0.9		Ω	

### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 233 $\mu$ H,  $R_G$  = 50 $\Omega$ ,  $I_{AS}$  = 100A,  $V_{GS}$  =10V.
- ⑤ Pulse width  $\leq 400\mu s$ ; duty cycle  $\leq 2\%$ .
- ©  $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- $\odot$  C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- ®  $R_{\theta}$  is measured at  $T_{J}$  approximately 90°C.
- Limited by  $T_{Jmax}$ , starting  $T_J = 25$   $^{\circ}$ C, L = 1mH,  $R_G = 50Ω$ ,  $I_{AS} = 63A$ ,  $V_{GS} = 10V$ .
- Pulse drain current is limited at 780A by source bonding technology.



# Dynamic Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	420			S	V <sub>DS</sub> = 10V, I <sub>D</sub> =100A
$Q_g$	Total Gate Charge		552	830		I <sub>D</sub> = 100A
$Q_{gs}$	Gate-to-Source Charge		119		nC	V <sub>DS</sub> = 38V
$Q_{gd}$	Gate-to-Drain Charge		168		IIC	V <sub>GS</sub> = 10V
Q <sub>sync</sub>	Total Gate Charge Sync. (Qg- Qgd)		384			
$t_{d(on)}$	Turn-On Delay Time		58			$V_{DD} = 38V$
t <sub>r</sub>	Rise Time		164			I <sub>D</sub> = 100A
$t_{d(off)}$	Turn-Off Delay Time		266		ns	$R_G = 2.6\Omega$
t <sub>f</sub>	Fall Time		160			V <sub>GS</sub> = 10V⑤
C <sub>iss</sub>	Input Capacitance		29550			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		2270			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		1395		pF	f = 100KHz, See Fig.7
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		2010			V <sub>GS</sub> = 0V, VDS = 0V to 60V⑦
Coss eff.(TR)	Output Capacitance (Time Related)		2560			V <sub>GS</sub> = 0V, VDS = 0V to 60V <sup>®</sup>

# **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			355①		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ②			1590⑩		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 100A, V_{GS} = 0V$ §
dv/dt	Peak Diode Recovery dv/dt@		8.6		V/ns	$T_J = 175^{\circ}C, I_S = 100A, V_{DS} = 75V$
+	Reverse Recovery Time		75		ns	$T_{J} = 25^{\circ}C$ $V_{DD} = 64V$
t <sub>rr</sub>	Reverse Recovery Time		80		115	$T_J = 125^{\circ}C$ $I_F = 100A$ ,
	Doverse Bessyery Charge		208		200	$T_{J} = 25^{\circ}C$ di/dt = 100A/µs \$
Q <sub>rr</sub>	Reverse Recovery Charge		251		nC	<u>T<sub>J</sub> = 125°C</u>
I <sub>RRM</sub>	Reverse Recovery Current		4.8		Α	T <sub>J</sub> = 25°C



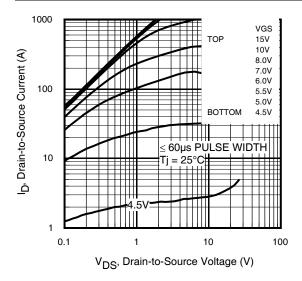


Fig 3. Typical Output Characteristics

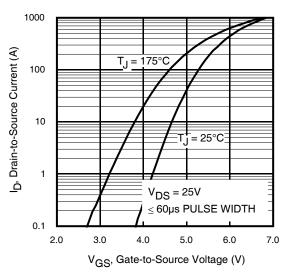


Fig 5. Typical Transfer Characteristics

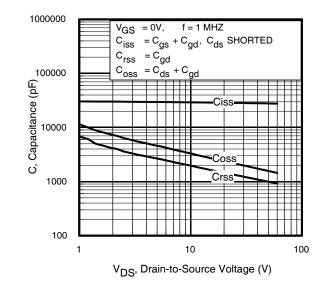


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

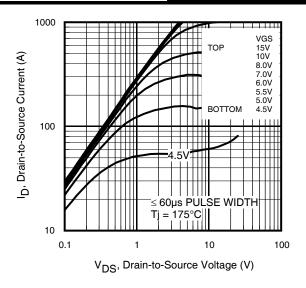


Fig 4. Typical Output Characteristics

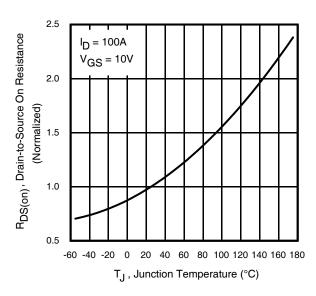


Fig 6. Normalized On-Resistance vs. Temperature

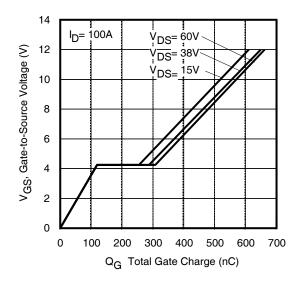


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage



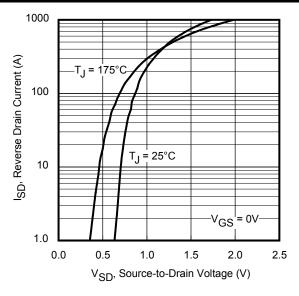


Fig 9. Typical Source-Drain Diode Forward Voltage

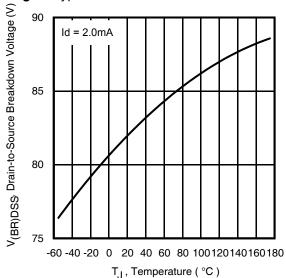


Fig 11. Drain-to-Source Breakdown Voltage

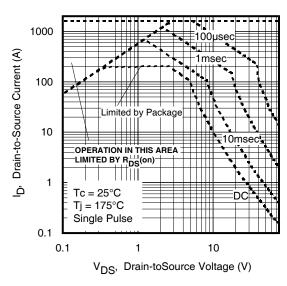


Fig 10. Maximum Safe Operating Area

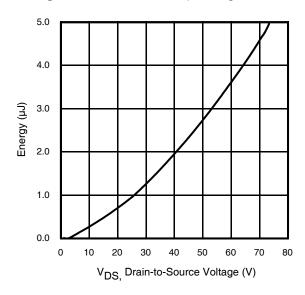


Fig 12. Typical Coss Stored Energy

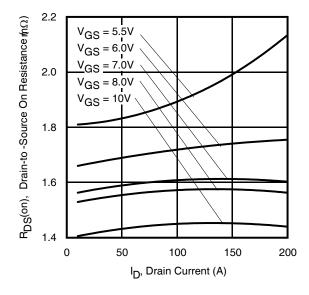


Fig 13. Typical On-Resistance vs. Drain Current

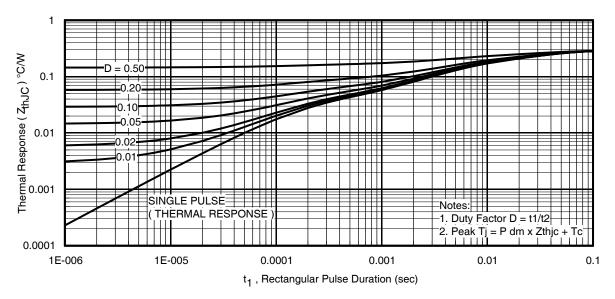


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

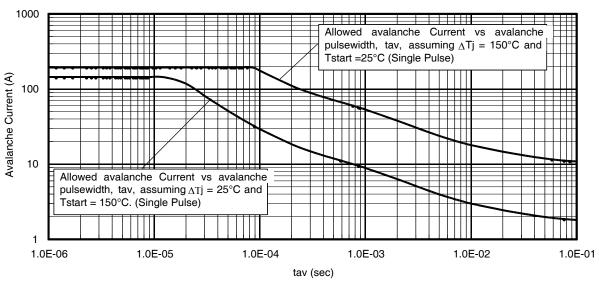


Fig 15. Avalanche Current vs. Pulse width

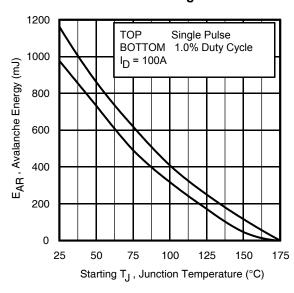


Fig 16. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{\text{jmax}}$ . This is validated for every part type.

- 2. Safe operation in Avalanche is allowed as long  $asT_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

 $t_{av}$  = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

PD (ave) = 1/2 ( 1.3·BV· $I_{av}$ ) =  $\Delta T/Z_{thJC}$ 

 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$ 

 $E_{AS (AR)} = P_{D (ave)} t_{av}$ 



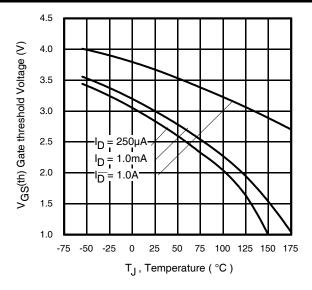


Fig 17. Threshold Voltage vs. Temperature

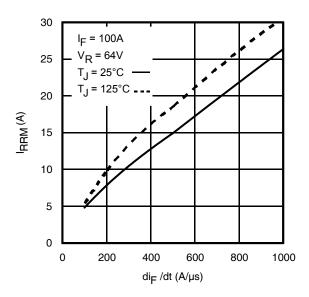


Fig 19. Typical Recovery Current vs. dif/dt

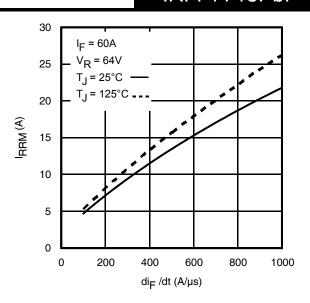


Fig 18. Typical Recovery Current vs. dif/dt

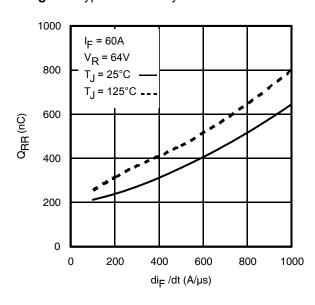


Fig 20. Typical Stored Charge vs. dif/dt

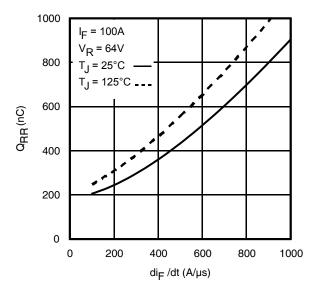


Fig 21. Typical Stored Charge vs. dif/dt



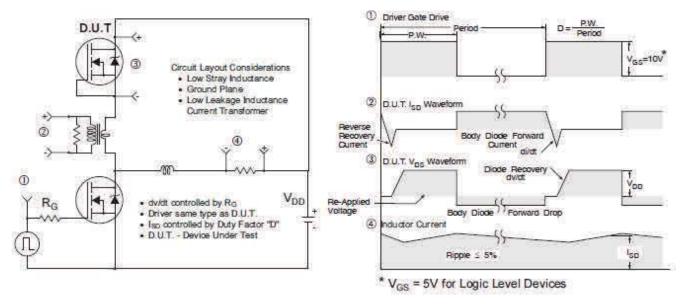


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

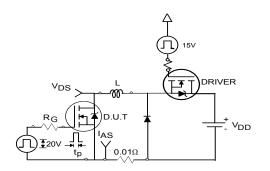


Fig 23a. Unclamped Inductive Test Circuit

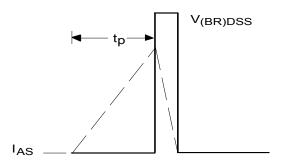


Fig 23b. Unclamped Inductive Waveforms

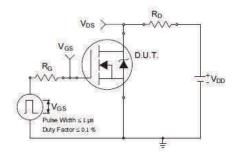


Fig 24a. Switching Time Test Circuit

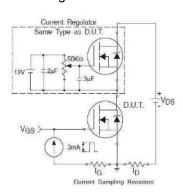


Fig 25a. Gate Charge Test Circuit

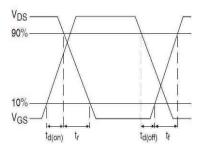


Fig 24b. Switching Time Waveforms

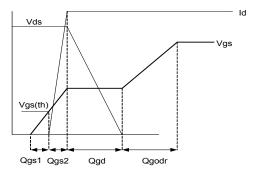
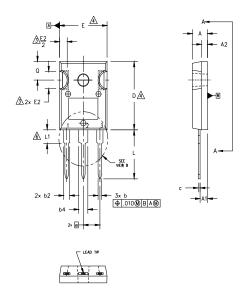


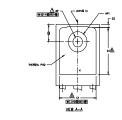
Fig 25b. Gate Charge Waveform

8



# TO-247AC Package Outline (Dimensions are shown in millimeters (inches))









#### NOTES:

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.

DIMENSIONS ARE SHOWN IN INCHES.

CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 ' TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

		DIMEN	ISIONS		
SYMBOL	INC	HES	MILLIM	ETERS	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
b1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.133	2.59	3.38	
С	.015	.035	0.38	0.89	
c1	.015	.033	0.38	0.84	
D	.776	.815	19.71	20.70	4
D1	.515	-	13.08	-	5
D2	.020	.053	0.51	1.35	
Ε	.602	.625	15.29	15.87	4
E1	.530	-	13.46	-	
E2	.178	.216	4.52	5.49	
е	.215	BSC	5.46	BSC	1
øk	.010		0.	25	
L	.559	.634	14.20	16.10	
L1	.146	.169	3.71	4.29	
øΡ	.140	.144	3.56	3.66	
øP1	-	.291	-	7.39	
Q	.209	.224	5.31	5.69	
S	.217	BSC	5.51	BSC	
					1

#### LEAD ASSIGNMENTS

# HEXFET

1.- GATE 2.- DRAIN

3.- SOURCE 4.- DRAIN

#### IGBTs, CoPACK

1.- GATE 2.- COLLECTOR

3.- EMITTER 4.- COLLECTOR

#### DIODES

1.- ANODE/OPEN

2.- CATHODE

3.- ANODE

# **TO-247AC Part Marking Information**

Notes: This part marking information applies to devices produced after 02/26/2001

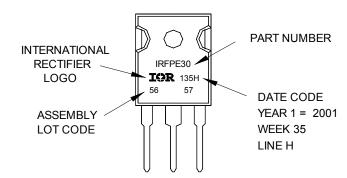
EXAMPLE: THIS IS AN IRFPE30

WITH ASSEMBLY LOT CODE 5657

ASSEMBLED ON WW 35, 2001

IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position indicates "Lead-Free"



TO-247AC package is not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

2015-11-30



# Qualification Information<sup>†</sup>

Qualification Level	Industrial			
Moisture Sensitivity Level	TO-247AC	N/A		
RoHS Compliant	Yes			

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/product-info/reliability/
- †† Applicable version of JEDEC standard at the time of product release.

# **Revision History**

Date	Comments
	<ul> <li>Updated E<sub>AS (L =1mH)</sub> = 2004mJ on page 2</li> <li>Updated note 9 "Limited by T<sub>Jmax</sub>, starting T<sub>J</sub> = 25°C, L = 1mH, R<sub>G</sub> = 50Ω, I<sub>AS</sub> = 63A, V<sub>GS</sub> =10V" on page 2</li> </ul>
1 1/30/2015	<ul> <li>Corrected fig 4 label typo from "25°C" to "175°C" on page 4.</li> <li>Updated datasheet with corporate template</li> </ul>

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